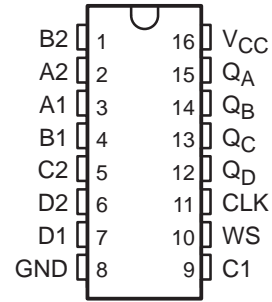


# SN74AS298A QUADRUPLE 2-INPUT MULTIPLEXER WITH STORAGE

SDAS219B – DECEMBER 1983 – REVISED DECEMBER 1994

- Selects One of Two 4-Bit Data Sources and Synchronously Stores Data With System Clock
- Applications:
  - Dual Source for Operands and Constants in Arithmetic Processor; Can Release Processor Register Files for Acquiring New Data
  - Implements Separate Registers Capable of Parallel Exchange of Contents, Yet Retains External Load Capability
  - Has Universal-Type Register for Implementing Various Shift Patterns, Including Compound Left-Right Capability
- Package Options Include Plastic Small-Outline (D) Packages and Standard Plastic (N) 300-mil DIPs

D OR N PACKAGE  
(TOP VIEW)



## description

The SN74AS298A is a quadruple 2-input multiplexer with storage that provides essentially the equivalent functional capabilities of two separate MSI functions (SN74AS157 and 'AS175A) in a 16-pin package.

When the word-select (WS) input is low, word 1 (A1, B1, C1, D1) is applied to the flip-flops. A high input to WS causes the selection of word 2 (A2, B2, C2, D2). The selected word is clocked to the output terminals on the negative-going edge of the clock pulse.

The SN74AS298A is characterized for operation from 0°C to 70°C.

FUNCTION TABLE

INPUTS		OUTPUTS†			
WS	CLK	QA	QB	QC	QD
L	↓	a1	b1	c1	d1
H	↓	a2	b2	c2	d2
X	H	QA0	QB0	QC0	QD0

† a1, a2, etc. = the level of steady-state input at A1, A2, etc.

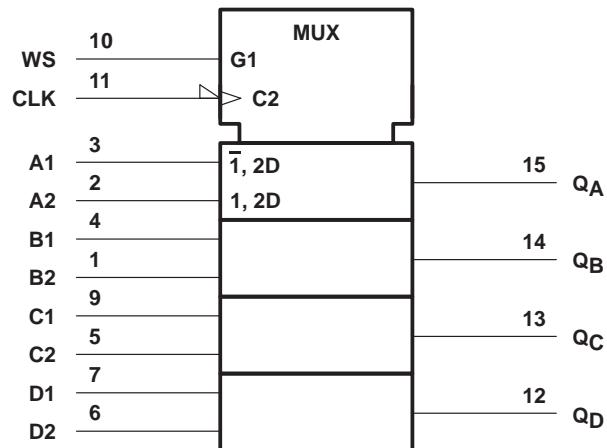
QA0, QB0, etc. = the level of QA, QB, etc. entered on the most recent ↓ transition of CLK

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## QUADRUPLE 2-INPUT MULTIPLEXER WITH STORAGE

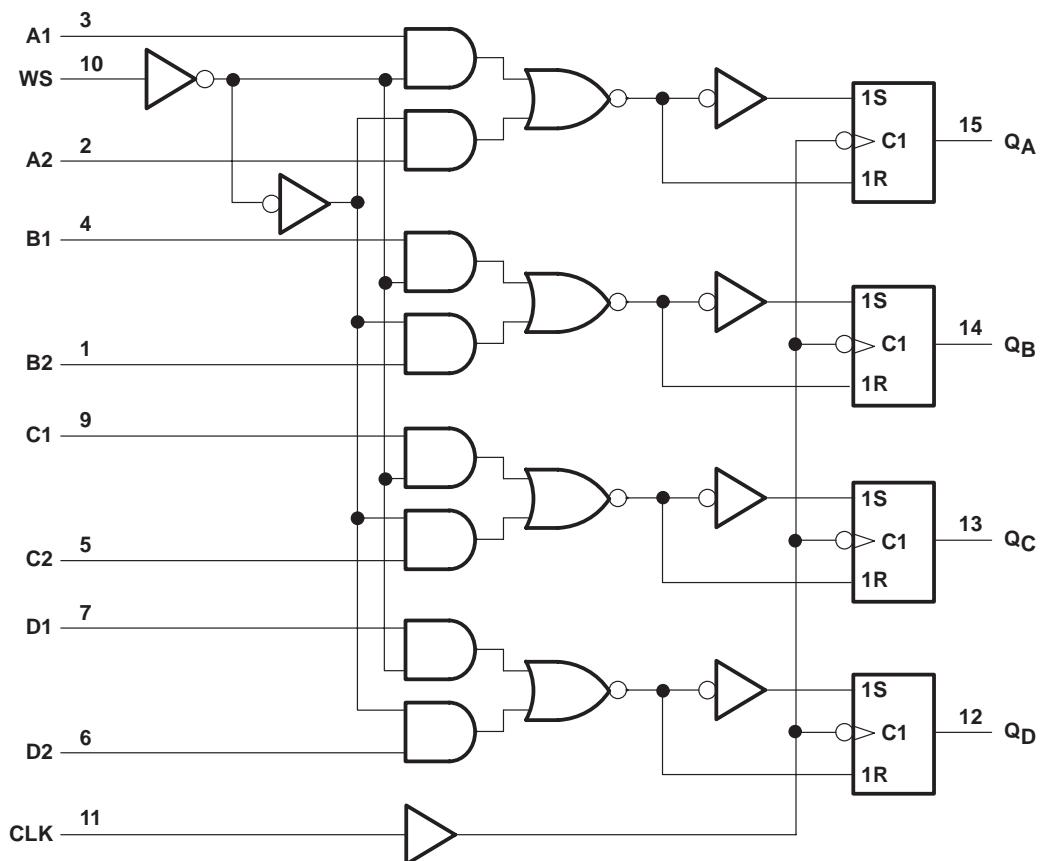
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### logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### logic diagram (positive logic)



**SN74AS298A**  
**QUADRUPL 2-INPUT MULTIPLEXER**  
**WITH STORAGE**

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**absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†**

Supply voltage, $V_{CC}$	7 V
Input voltage, $V_I$	7 V
Operating free-air temperature range, $T_A$	0°C to 70°C
Storage temperature range	65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

**recommended operating conditions**

	MIN	NOM	MAX	UNIT
$V_{CC}$ Supply voltage	4.5	5	5.5	V
$V_{IH}$ High-level input voltage	2			V
$V_{IL}$ Low-level input voltage			0.8	V
$I_{OH}$ High-level output current			–2	mA
$I_{OL}$ Low-level output current			20	mA
$T_A$ Operating free-air temperature	0		70	°C

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT
$V_{IK}$		$V_{CC} = 4.5\text{ V}$ , $I_I = -18\text{ mA}$				–1.2	V
$V_{OH}$		$V_{CC} = 4.5\text{ V to }5.5\text{ V}$ , $I_{OH} = -2\text{ mA}$		$V_{CC}-2$			V
$V_{OL}$		$V_{CC} = 4.5\text{ V}$ , $I_{OL} = 20\text{ mA}$			0.35	0.5	V
$I_I$		$V_{CC} = 5.5\text{ V}$ , $V_I = 7\text{ V}$				0.1	mA
$I_{IH}$	WS	$V_{CC} = 5.5\text{ V}$ , $V_I = 2.7\text{ V}$				40	$\mu\text{A}$
	All others					20	
$I_{IL}$	WS	$V_{CC} = 5.5\text{ V}$ , $V_I = 0.4\text{ V}$				–0.75	mA
	All others					–0.5	
$I_{OS}§$		$V_{CC} = 5.5\text{ V}$ , $V_O = 2.25\text{ V}$		–30		–112	mA
$I_{CCH}$		$V_{CC} = 5.5\text{ V}$			21	33	mA
$I_{CCL}$		$V_{CC} = 5.5\text{ V}$			22	36	mA

‡ All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current,  $I_{OS}$ .

**timing requirements over recommended operating free-air temperature range (unless otherwise noted)**

	MIN	MAX	UNIT
$f_{\text{clock}}$ Clock frequency	0	62	MHz
$t_w$ Pulse duration, CLK high or low	8		ns
$t_{su}$ Setup time before CLK↓	Data	4.5	ns
	WS	13	
$t_h$ Hold time after CLK↓	Data	3.5	ns
	WS	1	



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## QUADRUPLE 2-INPUT MULTIPLEXER WITH STORAGE

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
$f_{max}$			62		MHz
$t_{PLH}$	CLK	Q	2	9	ns
$t_{PHL}$			1	11	

### APPLICATION INFORMATION

This versatile multiplexer can be connected to operate as a shift register that can shift  $n$  places in a single clock pulse. Figure 1 illustrates a BCD shift register that shifts an entire 4-bit BCD digit in one clock pulse.

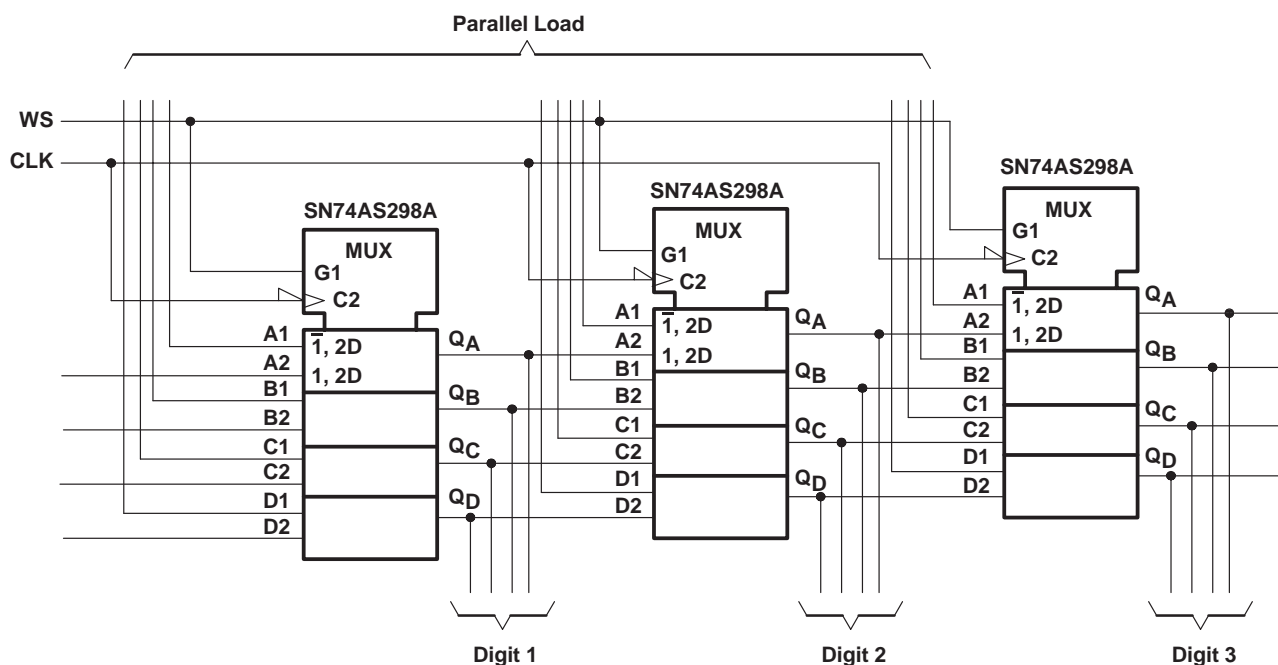


Figure 1. BCD Shift Register

When WS is high and the registers are clocked, the content of register 1 is transferred (shifted) to register 2, etc., effectively shifting the BCD digits one position. This application also retains a parallel-load capability, which means that new BCD data can be entered into the entire register with one clock pulse. This arrangement can be modified to perform the shifting of binary data for any number of bit locations.

Another function that can be implemented is a register designed specifically for supporting multiplier or division operations (see Figure 2).

When WS is low and the register is clocked, the outputs of the arithmetic/logic units (ALUs) are shifted one place. When WS is high and the registers are clocked, the data is shifted two places.

## APPLICATION INFORMATION

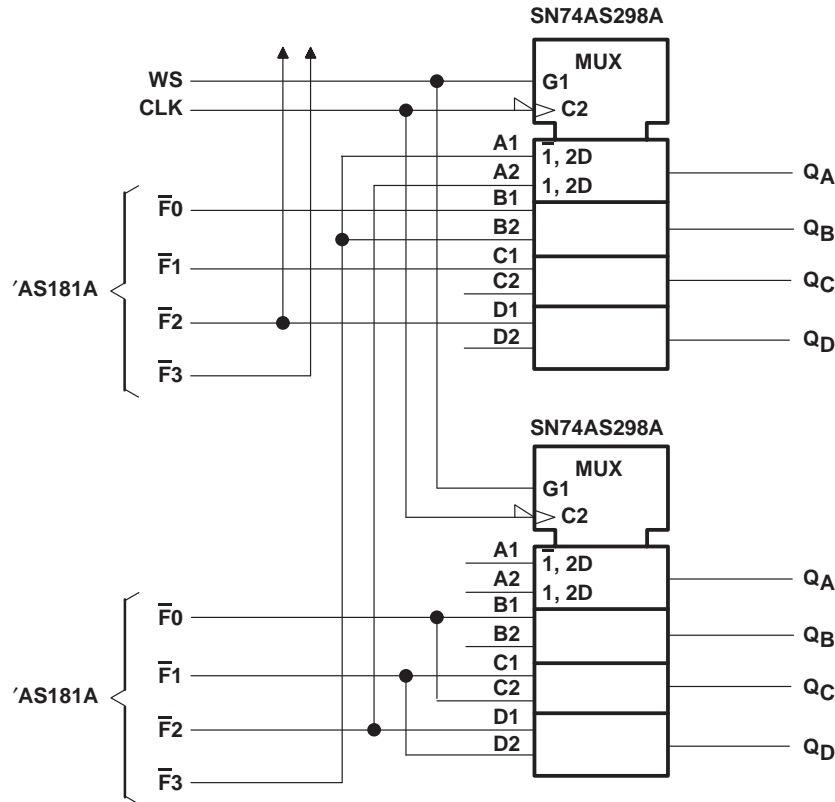


Figure 2. 1-Place/2-Place Shift Register

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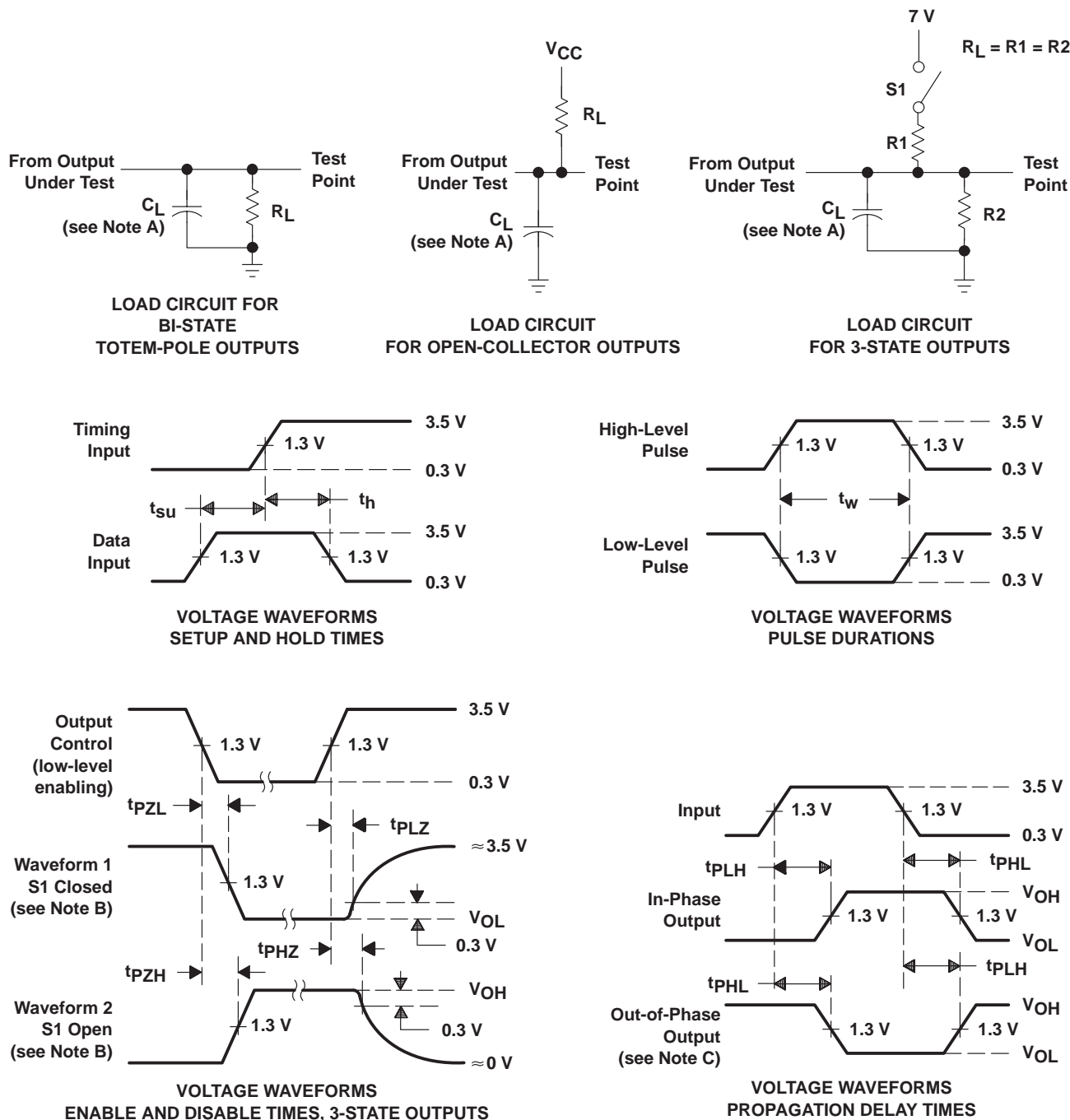
## QUADRUPLE 2-INPUT MULTIPLEXER

### WITH STORAGE

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#### PARAMETER MEASUREMENT INFORMATION

#### SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics:  $PRR \leq 1$  MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms

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